

Notice of References Cited	Application/Control No. 10/777,566		Applicant(s)/Patent Under Reexamination ESTRADA, JAMES J.	
	Examiner Brandon Hsieh		Art Unit 2128	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,969,045	11-1990	Haruki et al.	348/229.1
*	B	US-2004/0267854	12-2004	Haider et al.	708/512
*	C	US-2003/0021473	01-2003	Chiu, Sean	382/167
*	D	US-2002/0005911	01-2002	Motonakano et al.	348/675
*	E	US-6,771,839	08-2004	Westerman, Larry Alan	382/274
*	F	US-6,535,255	03-2003	Motonakano et al.	348/675
*	G	US-6,076,964	06-2000	Wu et al.	374/141
*	H	US-5,398,076	03-1995	Lum et al.	348/676
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hany Farid, Blind Inverse Gamma Correction, October 2001, IEEE Transactions on Image Processing, Vol. 10, No. 10
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.